ΗΙΟΚΙ

BATTERY TESTER Series

Measuring Battery Quality

Cells - Modules - Packs

Quality Testing Maintenance Inspections R & D

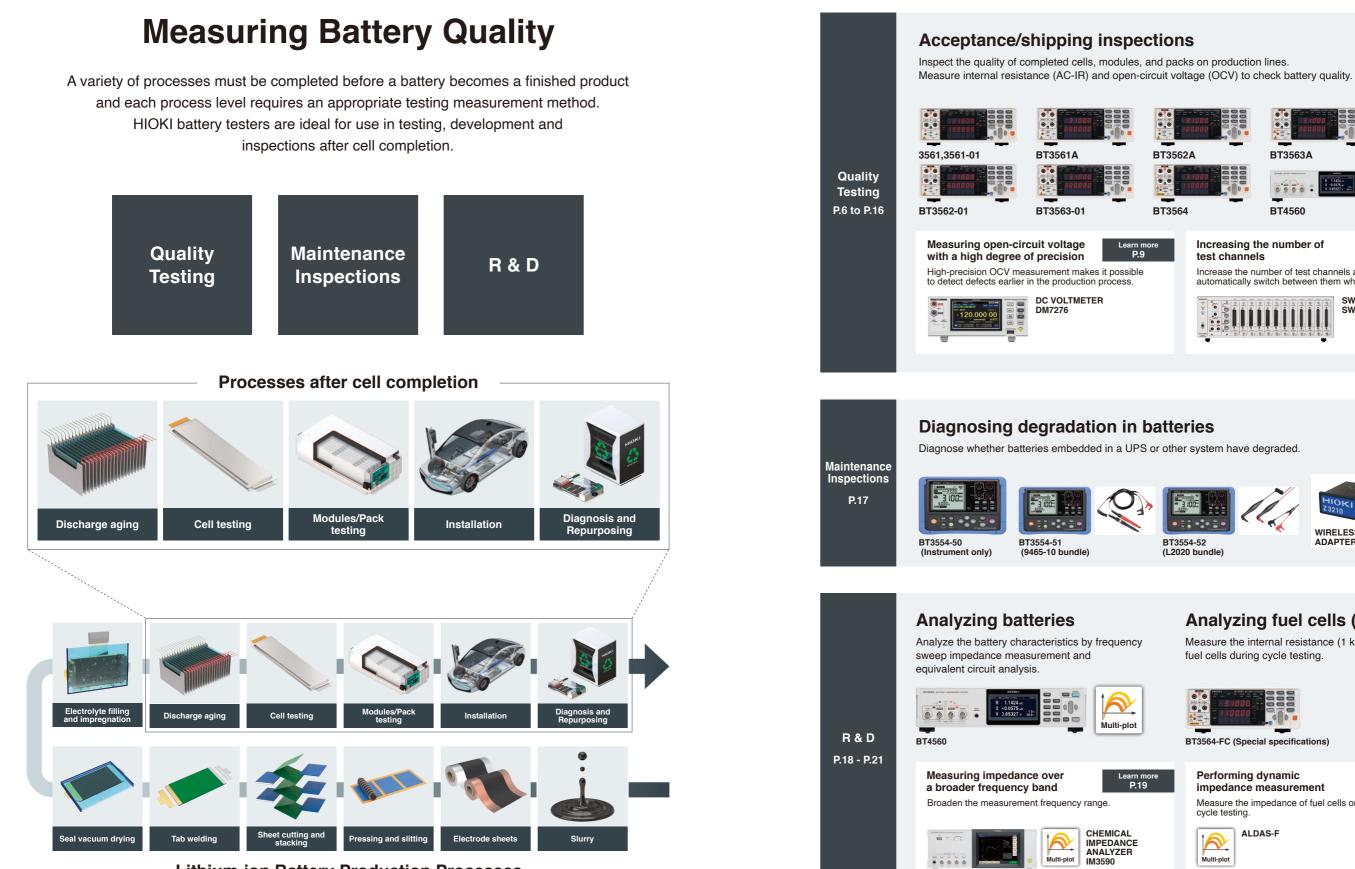








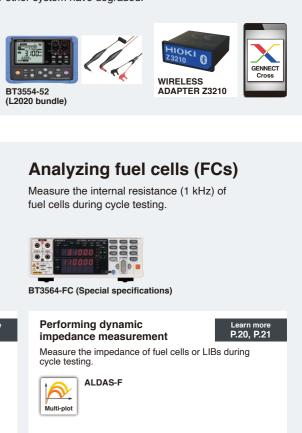
*1: BT3561A, BT3562A, BT3563A, BT3562-01, BT3563-01 only *2: BT3554-50, BT3554-51, BT3554-52 only



Lithium-ion Battery Production Processes







Battery tester lineup

				Acceptance/ship	ping inspections	
plication			Small cells for general purpose High speed sorting	Small cells for power motors Small packs of up to 60 V	Large cells for xEVs Mid-sized packs of up to 100 V	Large packs for xEVs Large packs of up to 300 V
el			3561, 3561-01	BT3561A	BT3562A	BT3563A
				NEW	NEW	NEW
earance			37000 2799999	3 x000 600000	31000 100000	
surement metho	d		AC four-terminal method	AC four-terminal method	AC four-terminal method	AC four-terminal method
surement freque	ncy		1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	1 kHz ±0.2 Hz
d input voltage			±22 V DC	±60 V DC	±100 V DC	±300 V DC
mum rated volta	ige to eart	h	±60 V DC	±60 V DC	±100 V DC	±300 V DC
		3 mΩ	N/A	N/A	3.1000 mΩ, 0.1 μΩ, 100 mA	3.1000 mΩ, 0.1 μΩ, 100 mA
esistance			N/A	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA
anges		300 mΩ	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA
-				, , ,	3.1000 Ω,100 μΩ, 1 mA	3.1000 Ω,100 μΩ, 1 mA
lax. display, esolution,					, , , ,	31.000 Ω, 1 mΩ, 100 μA
neasurement				, , , ,		310.00 Ω, 10 mΩ, 10 μA
urrent				, , , , , , , , , , , , , , , , , , ,	, , ,	3.1000 kΩ, 100 mΩ, 10 μA
		30 mO				±0.5% rdg ±10 dgt
du	Jourady	range or more				±0.5% rdg ±5 dgt 6.000 00 V, 10 μV
oltago						N/A
ieasurement						60.000 0 V, 100 μV
anges						N/A
lax display						300.000 V, 1 mV
esolution						N/A
Ba	asic accur					±0.01% rdg ±3 dgt
						10 ms
		Ω or V				4 ms, 12 ms, 35 ms, 150 ms
	M, SLOW	ΩV			8 ms, 24 ms, 70 ms, 253 ms	8 ms, 24 ms, 70 ms, 253 ms
able total line resi	stance "1 "3	SENSE line			6.5 Q. 6.5 Q. 30 Q. 30 Q	6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω
detection)		SOURCE line	Ν/Α, Ν/Α, 50 Ω, 500 Ω	Ν/Α, 5.5 Ω, 15 Ω, 150 Ω	5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω	5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω
		Ω or more	N/A, 7 V, 7 V peak	25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak
AN (TCP/IP, 10E	BASE-T/10	00BASE-TX)	N/A	YES	YES	YES
S-232C *4 (Max.	38400 bp	os)	YES	YES	YES	YES
SB			N/A	N/A	N/A	N/A
iP-IB			YES (3561-01 Only)	N/A	N/A	N/A
XT I/O (37-pin H	landler int	terface)	YES (36-pin)	YES	YES	YES
	OC 0 V to 3	3.1 V)	N/A	YES	YES	YES
ontact check			YES	YES	YES	YES
	`	,				YES
	rrent pulse	e output				YES
	tiono					Hi/ IN/ Lo
	uuus				,	Max. 30,000 YES
-						2 to 16 times
	lina					126
						400
	*5		YES	YES	YES	YES
icable standards			Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class A
t of radiated rad romagnetic field		псу	Resistant '6	Resistant '6	Resistant '6	Resistant "6
t of conducted		10 V	N/A	Resistant	Resistant	Resistant
romagnetic field		3 V	Resistant	Resistant	Resistant	Resistant
			YES	YES	YES	YES
*7			N/A	YES	YES	YES
ensions • Weight	t		215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)	215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)	215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)	215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)
	arance a	arance a	arance aurement method aurement frequency d input voltage mum rated voltage to earth as. display, solution, easurement arrent Basic accuracy blage easurement accuracy blage easurement accuracy blage	for general purpose High speed sorting arance 3561, 3561-01 arance	Tory general purpose Small packs of up to 60 V at 3561, 3561-01 BT3561A arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance Image: Small packs of up to 60 V arance <thimage: 60="" of="" packs="" small="" th="" to="" up="" v<=""> <t< td=""><td>or or general purpose in the procession of the phone of the</td></t<></thimage:>	or or general purpose in the procession of the phone of the

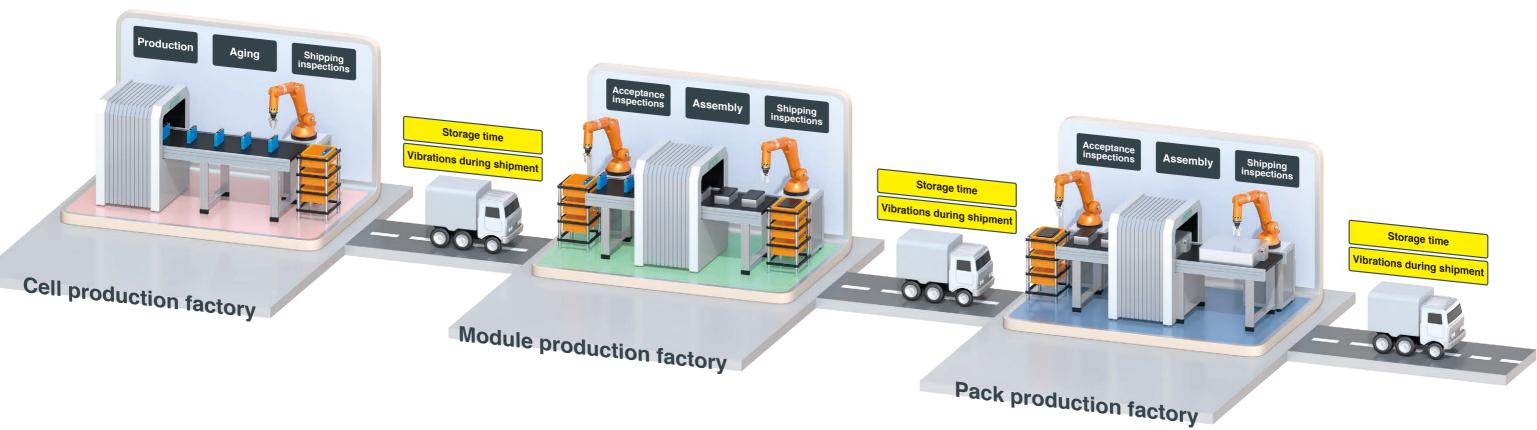
*1: Typical value *2: When the power supply frequency is 60 Hz *3: Total line resistance = wiring resistance + contact resistance + DUT resistance *4: Available as printer I/F *5: LabVIEW® Driver is a registered trademark of National Instruments Corporation *6: Test conditions were 80 MHz to 1 GHz at 10 V/m and 1 GHz to 6 GHz at 3 V/m, all at 80% AM *7: Canadian Standards Assosiation

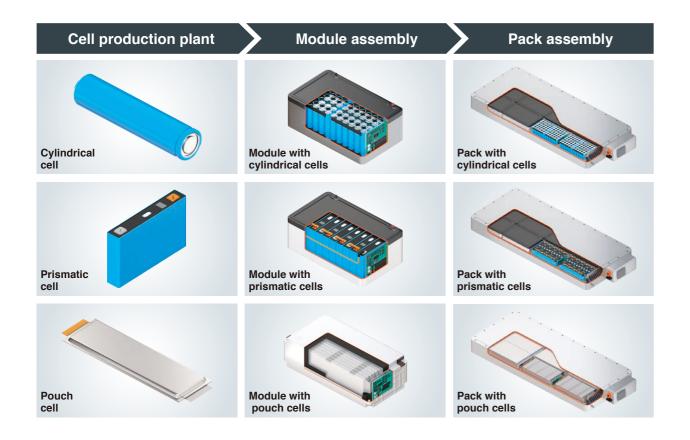
			Acceptance/ship	ping inspections	R & D	Maintenance	
Application			Extra large packs for xEV, ESS 1000 V high voltage model	GP-IB model	Cells or packs up to 20 V Degree of deterioration for reuse	Large-scale UPS	
Model			BT3564	BT3562-01 BT3563-01	BT4560	BT3554-50 ^{*10} BT3554-51 ^{*10} BT3554-52 ^{*10}	
			Special specifications for FCs available		Special specifications for 10 kHz available	NEW	
Appearance			97000 1778000	87000 600000	(Refer to P.19)		
Measurement meth	nod		AC four-terminal method	AC four-terminal method	AC four-terminal pair method	AC four-terminal method	
Measurement frequ	uency		1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	0.10 Hz to 1050 Hz	1 kHz ±80 Hz	
Rated input voltage	9		±1000 V DC	BT3562-01: ±70 V DC BT3563-01: ±300 V DC	±5 V DC Special specification supports up to ±20 V DC	±60 V DC	
Maximum rated vol	tage to eart	h	±1000 V DC	BT3562-01: ±60 V DC BT3563-01: ±300 V DC	SOURCE-H, SENSE-H: ±5 V DC SOURCE-L, SENSE-L: 0 V DC	±60 V DC	
		3 mΩ	3.1000 mΩ, 0.1 μΩ, 100 mA	3.1000 mΩ, 0.1 μΩ, 100 mA	Resistance (R)		
Resistance		30 mΩ	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA	3.6000 mΩ, 0.1 μΩ, 1.5 A 12.0000 mΩ, 0.1 μΩ, 500 mA	Resistance (R)	
measurement ranges		300 mΩ	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA	120.000 mΩ, 1 μΩ, 50 mA	3.100 mΩ, 1 μΩ, 160 mA	
-		3Ω	3.1000 Ω,100 μΩ, 1 mA	3.1000 Ω,100 μΩ, 1 mA	[The number of waveforms] Frequency: FAST, MEDIUM, SLOW	31.00 mΩ, 10 μΩ, 160 mA 310.0 mΩ, 100 μΩ, 16 mA	
Max. display, resolution,		30 Ω	31.000 Ω, 1 mΩ, 100 μΑ	31.000 Ω, 1 mΩ, 100 μΑ	0.10 Hz to 66 Hz: 1 wave, 2 waves, 8 waves	3.100 Ω, 1 mΩ, 1.6 mA [Basic accuracy]	
measurement		300 Ω	310.00 Ω, 10 mΩ, 10 μΑ	310.00 Ω, 10 mΩ, 10 μΑ	67 Hz to 250 Hz: 2 waves, 8 waves, 32 waves 260 Hz to 1050 Hz: 8 waves, 32 waves, 128 waves	±1.0% rdg ±8 dgt	
current _		3 kΩ 3 mΩ	3.1000 kΩ, 100 mΩ, 10 μA	3.1000 kΩ, 100 mΩ, 10 μA	Reactance (X)	$(3 \text{ m}\Omega \text{ range})$ ±0.8% rdg ±6 dgt	
	Basic accuracy	range 30 mΩ	±0.5% rdg ±10 dgt *8 ±0.5% rdg ±5 dgt *8	±0.5% rdg ±10 dgt ±0.5% rdg ±5 dgt	±3.6000 mΩ, 0.1 μΩ, 1.5 A ±12.0000 mΩ, 0.1 μΩ, 500 mA	$\pm 0.8\%$ rdg ± 6 dgt (30 m Ω range or more)	
eme		range or more 6 V	±0.5% Tug ±5 ugi *	6.000 00 V, 10 μV	±120.000 mΩ, 1 μΩ, 50 mA	Voltage (V)	
Voltage measurement		10 V	9.999 99 V, 10 µV	N/A	Impedance (Ζ) 3.6000 mΩ, 0.1 μΩ, 1.5 A	6.000 V, 1 mV	
		60 V	N/A	60.000 0 V, 100 μV	12.0000 mΩ, 0.1 μΩ, 500 mA 120.000 mΩ, 1 μΩ, 50 mA	60.00 V, 10 mV [Basic accuracy]	
ranges		100 V	99.999 9 V, 100 μV	N/A	Phase angle (θ)	±0.08% rdg ±6 dgt	
Max. display,		300 V	N/A	300.000 V, 1 mV (BT3563-01 only)	±180.000°, 0.001° [Basic accuracy] Refer to P.19	Temperature (°C)	
resolution		1000 V	1100.00 V, 1 mV '9	N/A	Voltage (V)	-10.0°C to 60.0°C, 0.1°C	
	Basic accur	acy	±0.01% rdg ±3 dgt "8	±0.01% rdg ±3 dgt	±5.10000 V, 10 μV [Basic accuracy] ±0.0035% rdg ±5 dgt		
Response time *1			700 ms 10 ms [Sampling period] N/4 12 ms 35 ms 253 ms 4 ms 12 ms 35 ms 150 ms			1.6 s	
Sampling period "2 EX.FAST, FAST, MEDI	ILIM SLOW	Ω or V ΩV	N/A, 12 ms, 35 ms, 253 ms N/A, 28 ms, 74 ms, 359 ms	4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms	0.1 s, 0.4 s, 1.0 s	N/A 100 ms	
	,				Temperature (°C) -10.0°C to 60.0°C, 0.1°C	N/A	
Ilowable total line resistance "1 "3 SENSE line		$\begin{array}{c c c c c c c c c c c c c c c c c c c $		N/A N/A			
(error detection)	800 mΩ, 3 Ω			2 32, 2 32, 10 32, 100 32		N/A	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta	age	SOURCE line	3 Ω, 3 Ω, 20 Ω, 200 Ω 25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak	3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω	N/A 5 V max	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta	age s, 300 mΩ, 3 0	Ω or more			SENSE line: 10 Ω, 15 Ω, 50 Ω	5 V max	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less	age s, 300 mΩ, 3 9 0BASE-T/10	Ω or more DOBASE-TX)	25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES	5 V max • USB • Wireless communications	
(error detection) Panges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Maz USB	age s, 300 mΩ, 3 9 0BASE-T/10	Ω or more DOBASE-TX)	25 V, 7 V, 4 V peak N/A YES N/A	25 V, 7 V, 4 V peak N/A YES N/A	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES YES	5 V max	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Maz USB GP-IB	age s, 300 mΩ, 3 9 0BASE-T/10 x. 38400 bp	Ω or more D0BASE-TX) Is)	25 V, 7 V, 4 V peak N/A YES N/A YES	25 V, 7 V, 4 V peak N/A YES N/A YES	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES YES N/A	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin	age s, 300 mΩ, 3 Ω 0BASE-T/10 x. 38400 bp Handler int	Ω or more DOBASE-TX) is) terface)	25 V, 7 V, 4 V peak N/A YES N/A YES YES	25 V, 7 V, 4 V peak N/A YES N/A YES YES	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES YES N/A YES	5 V max • USB • Wireless communications (*when Z3210 installed)	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin Analog output (age s, 300 mΩ, 3 Ω 0BASE-T/10 x. 38400 bp Handler int	Ω or more DOBASE-TX) is) terface)	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES N/A YES N/A YES N/A YES N/A	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin	age s, 300 mΩ, 3 i 0BASE-T/1(x. 38400 bp Handler int (DC 0 V to 3	Ω or more D0BASE-TX) is) terface) 3.1 V)	25 V, 7 V, 4 V peak N/A YES N/A YES YES	25 V, 7 V, 4 V peak N/A YES N/A YES YES	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES YES N/A YES	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Measurement Navigator (When using Z3210,	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin Analog output (Contact check	age s, 300 mΩ, 3 i 0BASE-T/10 x. 38400 bp i Handler int (DC 0 V to 3 it (±1000 co	Ω or more DOBASE-TX) is) terface) 3.1 V) unts)	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES N/A YES N/A YES N/A YES N/A YES	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin Analog output (Contact check Zero adjustmen	age s, 300 mΩ, 3 i 0BASE-T/10 x. 38400 bp i Handler int (DC 0 V to 3 it (±1000 co	Ω or more DOBASE-TX) is) terface) 3.1 V) unts)	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES YES	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES YES	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto hold function • Auto-hold function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output) • Auto power-off	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin Analog output (Contact check Zero adjustmen Measurement c	age s, 300 mΩ, 3 s 0BASE-T/10 x. 38400 bp t Handler int (DC 0 V to 3 tt (±1000 co urrent pulse	Ω or more DOBASE-TX) is) terface) 3.1 V) unts)	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES YES YES	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES YES YES	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES N/A YES N/A YES N/A YES N/A YES N/A YES YES YES YES YES	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output) • Auto power-off • Tablet app	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin Analog output (Contact check Zero adjustmen Measurement cr Comparator Statistical calcul Delay	age s, 300 mΩ, 3 s 0BASE-T/10 x. 38400 bp t Handler int (DC 0 V to 3 tt (±1000 co urrent pulse	Ω or more DOBASE-TX) is) terface) 3.1 V) unts)	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES N/A YES N/A YES N/A YES Hi/ IN/ Lo N/A YES YES YES YES YES YES YES Hi/ IN/ Lo N/A YES	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross • Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin Analog output (Contact check Zero adjustmen Measurement ci Comparator Statistical calcul Delay Average	age s, 300 mΩ, 3 6 0BASE-T/10 x. 38400 bp I Handler int (DC 0 V to 3 it (±1000 co urrent pulse lations	Ω or more DOBASE-TX) is) terface) 3.1 V) unts)	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES N/A YES N/A YES N/A YES Hi/ IN/ Lo N/A YES YES YES YES YES YES YES Hi/ IN/ Lo N/A YES 1 to 99 times	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT One) • Comparator function	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin Analog output (Contact check Zero adjustmen Measurement cr Comparator Statistical calcul Delay Average Panel saving/loc	age s, 300 mΩ, 3 6 0BASE-T/10 x. 38400 bp I Handler int (DC 0 V to 3 it (±1000 co urrent pulse lations	Ω or more DOBASE-TX) is) terface) 3.1 V) unts)	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES Hi/ IN/ Lo N/A YES 1 to 99 times 126	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT Ore) • Comparator function (PASS/ WARNING/ FAIL)	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin Analog output (Contact check Zero adjustmen Measurement cr Comparator Statistical calcul Delay Average Panel saving/loc Memory storage	age s, 300 mΩ, 3 s 0BASE-T/10 x. 38400 bp i Handler int (DC 0 V to 3 it (±1000 co urrent pulse lations ading e	Ω or more DOBASE-TX) is) terface) 3.1 V) unts)	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT Ore) • Comparator function (PASS/ WARNING/ FAIL)	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin Analog output (Contact check Zero adjustmen Measurement ct Comparator Statistical calcul Delay Average Panel saving/log Memory storage LabVIEW® drive	age s, 300 mΩ, 3 (0BASE-T/10 x. 38400 bp i Handler int (DC 0 V to 3 it (±1000 co urrent pulse lations ading e e	Ω or more DOBASE-TX) is) terface) 3.1 V) unts)	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES 100 y ES 110 y9 times 126 N/A YES	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross • Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT One) • Comparator function (PASS/ WARNING/ FAIL) • Excel® Direct Input functivi (When using Z3210)	
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(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin Analog output (Contact check Zero adjustmen Measurement cr Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive Applicable standard Effect of radiated ra Effect of conducted	age s, 300 mΩ, 3 (0BASE-T/10 x. 38400 bp i Handler int (DC 0 V to 3 it (±1000 co urrent pulse lations ading e er '5 ds adio-frequer Id	Ω or more DOBASE-TX) is) verface) 3.1 V) unts) e output	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant ¹⁸	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant '8	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES N/A YES N/A YES N/A YES N/A YES Hi/ IN/ LO N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant '8	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT Cross) • PC app (GENNECT Cross) • PC app (GENNECT Cross) • Comparator function (PASS/ WARNING/ FAIL) • Excel® Direct Input function (When using Z3210) Safety: EN61010 EMC: EN61326 Class E Resistant (3 V/m)	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3 Open terminal volta Ranges: 30 mΩ or less LAN (TCP/IP, 10 RS-232C ⁻⁴ (Max USB GP-IB EXT I/O (37-pin Analog output (Contact check Zero adjustmen Measurement cr Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive Applicable standard Effect of radiated radiofrequency electromagnetic fiel Effect of conducted radiofrequency electromagnetic fiel	age s, 300 mΩ, 3 (0BASE-T/10 x. 38400 bp i Handler int (DC 0 V to 3 it (±1000 co urrent pulse lations ading e er '5 ds adio-frequer Id	Ω or more D0BASE-TX) is) ierface) 3.1 V) unts) e output output ncy 10 V	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant ¹⁶ N/A Resistant YES	25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant ^{*6} N/A Resistant YES	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant '8 N/A YES	5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto hold function • Measurement Navigator (When using Z3210, GENNECT Cross • Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT Cross) • PC app (GENNECT Cross) • PC app (GENNECT One) • Comparator function (PASS/WARNING/ FAIL) • Excel® Direct Input functiv (When using Z3210) Safety: EN61010 EMC: EN61326 Class E Resistant (3 V/m) N/A N/A YES	
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*8: Average function: When set to ON 4 times *9: Resolution 10 mV for 1000.00 V or more *10: -50: Instrument only, -51: 9465-10 bundle, -52: L2020 bundle *11: Zero-adjustment range R: ±0.1000 mΩ (3 mΩ range), ±0.3000 mΩ (10 mΩ range), ±3.000 mΩ (100 mΩ range), X: ±1.5000 mΩ (Common for all ranges), V: ±0.10000 V

6

Measuring battery performance and safety





Measuring battery performance and safety using internal resistance (AC-IR) and open-circuit voltage (OCV)

Testing plays an important role in production processes by allowing plants to manufacture safe, high-performance batteries. During shipping and acceptance inspections, technicians assess battery performance by measuring internal resistance and safety by measuring open-circuit voltage.

Our Battery testers meet these needs...

"We want to manufacture batteries with stable performance."

"We want to manufacture highly safe batteries."

Assembly process (from cell batteries to pack batteries)

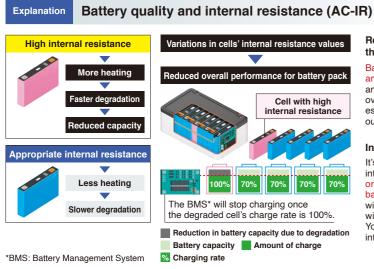
Cells produced at the cell production factory are shipped to the module production factory after undergoing a shipping inspection. Since factors such as vibrations during shipment and even the passage of time can cause defects, batteries undergo an acceptance inspection before being assembled into modules and packs.

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3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Measuring battery performance and safety

Manufacturing batteries with stable performance



Relationship between the internal resistance and the decline of battery cell capacity

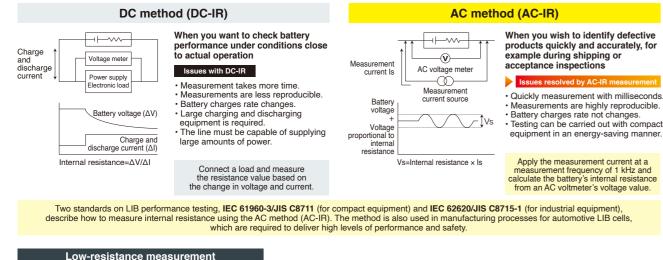
Battery cells with high internal resistance tend to generate more heat and degrade faster. When cells degrade, their capacity declines, and their internal resistance rises. Internal resistance also changes over time or as a consequence of vibrations during shipment. It's essential to eliminate cells with high internal resistance by carrying out an inspection each time cells are shipped or received.

Internal resistance and battery pack performance

It's important that all the cells in a given battery pack have uniform internal resistance. If one or more cells have high internal resistance or have degraded, they will become a bottleneck and limit the battery pack's capacity. Moreover, the battery pack's performance will rapidly decline as the BMS* attempts to protect degraded cells with reduced capacity from overcharging and over-discharging. You can improve battery cell quality by selecting cells with uniform internal resistance so that they will degrade uniformity.

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

There are two methods for measuring a battery's internal resistance: the AC method and the DC method. Resistance values are known as AC-IR when measured using the AC method, and as DC-IR when measured using the DC method. AC-IR and DC-IR have a complementary relationship, and it's recommended to choose the one that best suits your application, or to carry out both measurements. HIOKI battery testers can perform 4-terminal AC-IR measurement.

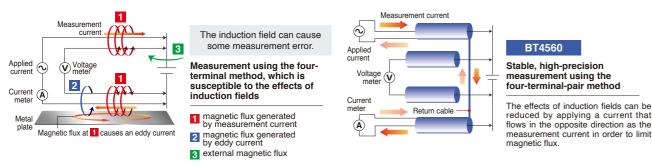


(1 mΩ and lower) for large batteries

Internal resistance measurement (AC-IR measurement)

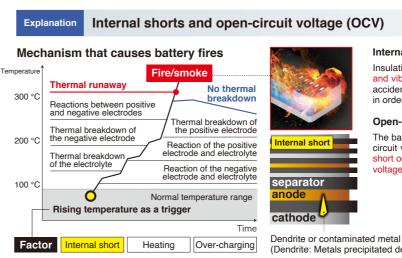
BT4560

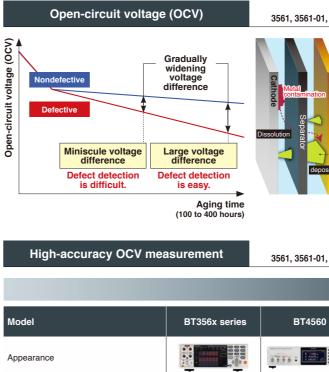
The larger the battery, the lower its internal resistance. Large batteries used in automobiles and infrastructure applications sometimes have internal resistance values of less than 1 mΩ. The BT4560's four-terminal-pair measurement method, which reduces the effects of induction fields, is an optimal solution for accurately measuring such low resistance levels.



Measuring battery performance and safety

Manufacturing highly safe batteries





Recommended range for 4 V measurement	6 V range	5 V range
Number of digit, Max. Display	5 1/2 digit, 6.000 00	5 1/2 digit, 5.100
Resolution'1	10 µV	10 µV
Basic accuracy*1	±0.01% rdg ±3 dgt	±0.0035% rdg ±5
Measurement error*1*2	±430 μV	±190 μV
Period of accuracy guarantee	1 year	1 year
Temperature measurement	N/A	YES
Temperature Compensation Function	N/A	N/A

*1: When using recommended range for 4 V measurement *2: When measuring a 4 V LIB cell

Internal shorts

Insulation defects, which can be caused by factors such as ageing and vibrations during shipment, can lead to fire and other dangerous accidents, making it necessary to check open-circuit voltage values in order to distinguish between defective and non-defective products.

Open-circuit voltage (OCV)

The battery voltage when no load is connected is known as the opencircuit voltage (OCV). When an insulation defect such as an internal short occurs inside the battery, self-discharge causes the open-circuit voltage to decrease

(Dendrite: Metals precipitated dendritic form)

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560, DM7276



Since the amount of change in OCV caused by self-discharge is extremely small, it is necessary to age batteries at least 100 to 400 hours before testing can accurately distinguish between non-defective and defective products. Additionally, it is necessary to measure OCV multiple times during the aging process. Using an instrument with good accuracy makes it possible to remove defects from the testing line earlier in the process, significantly reducing management and testing costs.

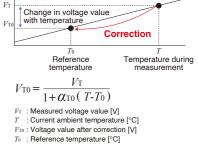
Dendrites form over time as minuscule metal fragment contaminants dissolve, leading to internal shorts.

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560, DM7276

High-accuracy							
DM7276 (DC VOLTMETER)							
10 V range							
7 1/2 digit, 12.000 000							
1 µV							
$\pm 0.0009\%$ rdg $\pm 12~\mu V$							
±48 μV							
1 year							
YES							
YES							

OCV fluctuates with the ambient temperature

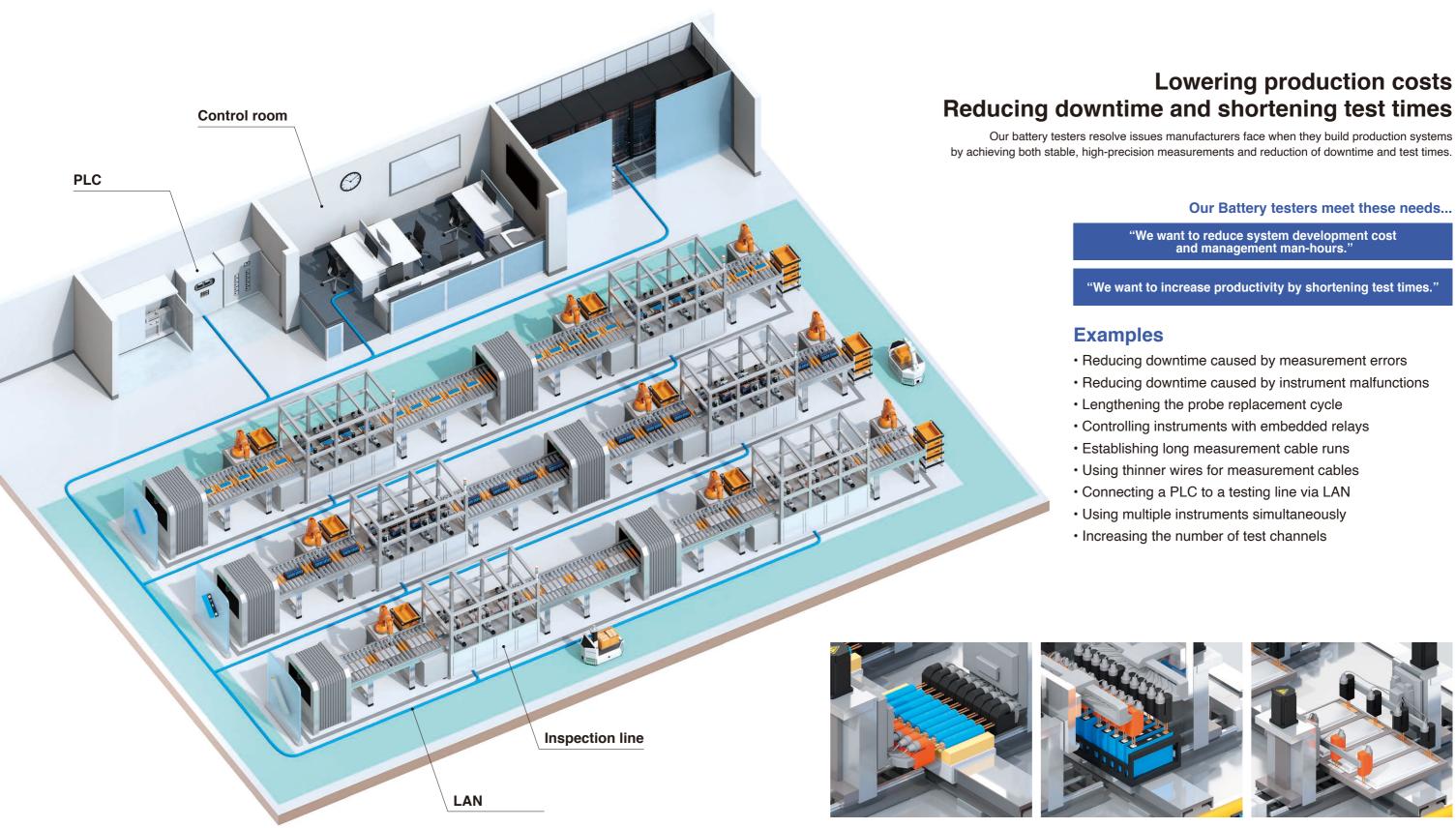
A battery's OCV value can fluctuate several hundred microvolts with a change of just 1°C in the ambient temperature. Temperature correction functionality allows the instrument to display a value that has been converted to the voltage at the reference temperature.



- α_{T0} : Temperature coefficient at T_0 [1/°C]

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Integrate to automatic testing system



Testing of prismatic cells

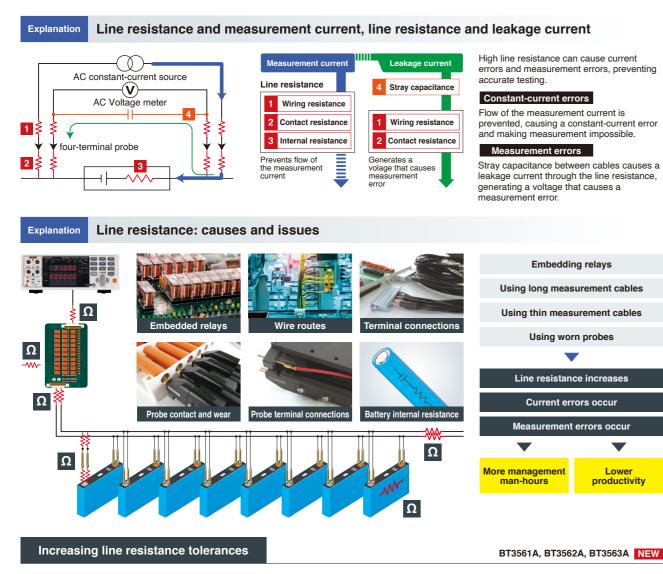
Testing of pouch cells

Acceptance/shipping inspections

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

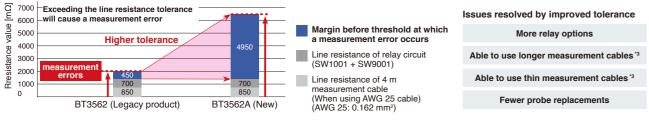
Integrate to automatic testing system

Reducing test system development cost and management man-hours



The new BT356xA has dramatically improved tolerances for line resistance compared to previous models. This improvement makes it easy to build test systems with large numbers of channels using relays. Additionally, a longer maintenance cycle for systems in use means fewer maintenance man-hours. Finally, its capability to handle thinner cables than with previous models⁻³ makes it easier to route cables.

(SENSE side when using 3 m Ω or 30 m Ω range)

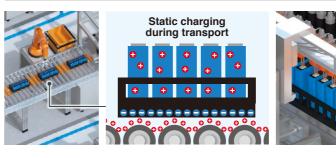


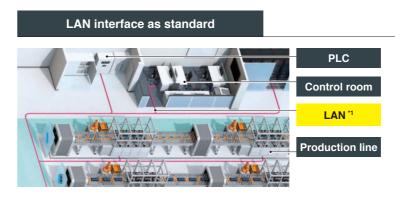
Model 3561, 3561-01			BT3561A			BT3562A, BT3563A				BT3562-01, BT3563-01, BT3564							
Range		3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω
Measurement current		N/A	N/A	10 mA	1 mA	N/A	100 mA	10 mA	1 mA	100 mA	100 mA	10 mA	1 mA	100 mA	100 mA	10 mA	1 mA
Allowable total line resistance	SENSE line	N/A	N/A	20 Ω	20 Ω	N/A	6.5 Ω	30 Ω	30 Ω	6.5 Ω	6.5 Ω	30 Ω	30 Ω	2Ω	2 Ω	15 Ω	15 Ω
(error detection) *1 *2	SOURCE line	N/A	N/A	50 Ω	500 Ω	N/A	5.5 Ω	15 Ω	150 Ω	5.5 Ω	5.5 Ω	15 Ω	150 Ω	2Ω	2Ω	15 Ω	150 Ω

*1: Typical value *2: Total line resistance = (Wiring resistance + Contact resistance + DUT resistance)

*3: AWG 29 (0.064 mm²) wire equivalent to 2.2 Ω over an 8 m round trip can be used with the 3 m Ω or 30 m Ω range.

Preventing instrument malfunctions caused by static electricity

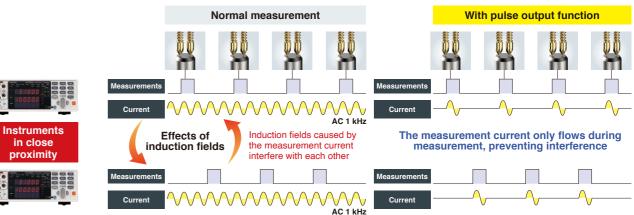






Using multiple instruments simultaneously

When multiple battery testers are used at the same time, their induction fields can interfere with each other, causing measurement errors. Since the instruments' measurement currents flow continuously, such interference can occur even if measurements are timed so that they don't occur simultaneously. The measurement current pulse output function allows the measurement current to flow only during measurement. By using this function to make alternating measurements, you can avoid the effects of interference between induction fields caused by the measurement current.



BT3561A, BT3562A, BT3563A NEW



Batteries can become charged on production lines, for example, when being transported on a conveyor belt. When probes are placed in contact with such batteries, the resulting application of static electricity can then damage the instrument. The BT356xA series is designed to withstand contact with ± 30 kV of static electricity*, preventing static-caused malfunctions and reducing testing line downtime.

* ±30 kV IEC 61000-4-2 contact discharge

BT3561A, BT3562A, BT3563A NEW

The BT356xA series is equipped with a LAN interface as standard equipment, making it easy for the instrument to interoperate with a PLC²-based control system. The ability to use readily accessible LAN cables helps lower costs during system development and maintenance. Furthermore, a design with strong noise and static electricity resistance helps avoid system problems.

*1: Max.30 m *2: Programmable Logic Controller, a device that automatically controls one or more machines

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

OK

Accurate probing is essential for accurate measurement. Our battery testers are equipped with probe contact monitoring functionality to ensure highly reliable testing.

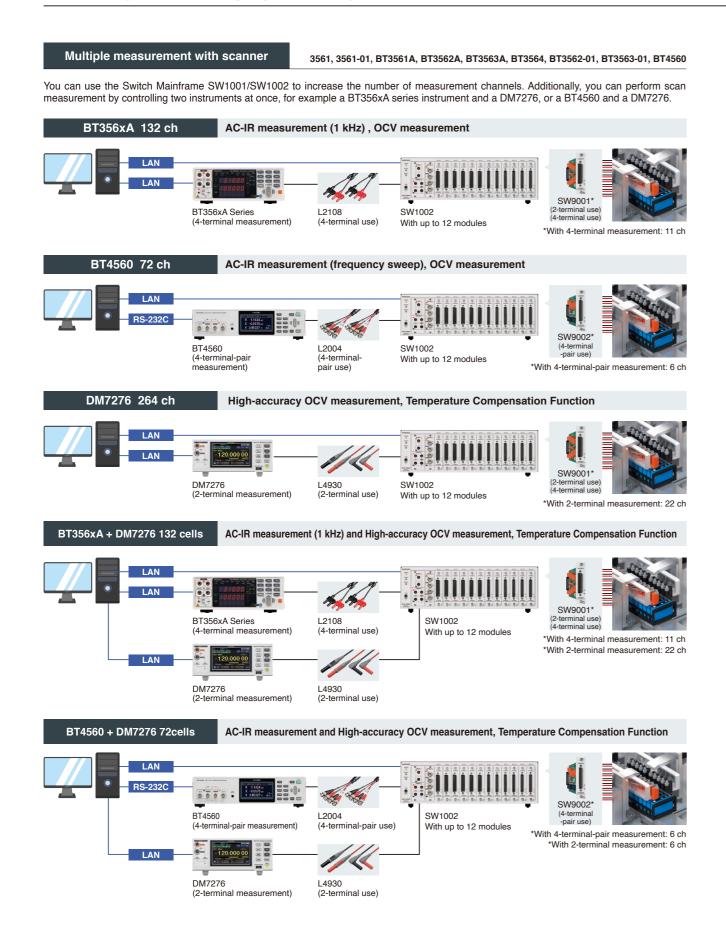
BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

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3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Integrate to automatic testing system

Improving productivity by reducing test times



Configuration Example of Multi-channel Battery Testing

Number of instruments in use	AC-IR measurement 1 kHz	AC-IR measurement frequency sweep	OCV measurement	High-accuracy OCV measurement Temperature Compensation Function	Connection cable	Switch mainframe	Module	Maximum number of channels
1	YES	N/A	YES	N/A	L2108	SW1002	SW9001	132 ch
1	YES	YES	YES	N/A	L2004	SW1002	SW9002	72 ch
1	N/A	N/A	N/A	YES	L4930	SW1002	SW9001	264 ch
2	YES	N/A	YES	N/A	L2108	SW1002	014/0001	100 sh
(switched)	N/A	N/A	N/A	YES	L4930	instrument	500001	132 ch
2	YES	YES	YES	N/A	L2004	SW1002	014/0000	70
(switched)	N/A	N/A	N/A	YES	L4930	instrument	5009002	72 ch
	instruments in use 1 1 1 2 (switched) 2	instruments in use in u	instruments in use measurement 1 kHz measurement frequency sweep 1 YES N/A 1 YES YES 1 N/A N/A 2 (switched) YES N/A 2 YES N/A 2 YES N/A 2 YES YES 2 YES YES	instrumentsmeasurement 1 kHzmeasurement frequency sweepCCV measurement1YESN/AYES1YESYESYES1N/AN/AN/A2 (switched)YESN/AYES0YESN/AN/A2 (switched)YESYESYES1YESN/AN/A2 (switched)YESYESYES1YESYESYES	Number of instruments AC-In trequency sweep OCV measurement measurement OCV measurement OVV OVV	Number of in strumentsAccin measurement 1 kHzAccin measurement frequency sweepOCV measurement measurement measurementOCV measurement CompensationConnection cable1YESN/AYESN/AL21081YESYESYESN/AL20041N/AN/AN/AYESL49302 (switched)YESN/AN/AL21080YESYESYESN/AL20041N/AN/AN/AYESL49302 (switched)N/AN/AN/AYESL49302 (condected)YESYESYESN/AL2004	Number of in usesmeasurement 1 kHzACUMENT measurement frequency sweepOCV measurement measurement measurementOCV measurement measurement compensation FunctionConnection cableSwitch mainframe1YESN/AYESN/AL2108SW10021YESYESYESN/AL2004SW10021N/AN/AN/AYESL4930SW10021N/AN/AYESN/AL2108SW10022 (switched)YESN/AYESN/AL21082 (switched)YESN/AYESN/AL21082 (switched)YESYESN/ASW10022 (switched)YESYESYESSW1002 Switching instrument2 (switched)YESYESYESSW1002 Switching2 (switched)YESYESYESSW1002 Switching	Multiber of in usesmeasurement 1 kHzAC-In measurement frequency sweepOCV measurement measurement measurementOCV Compensation FunctionConnection cableSwitch mainframeModule1YESN/AYESN/AL2108SW1002SW90011YESYESYESN/AL2004SW1002SW90021N/AN/AN/AYESL4930SW1002SW90012 (switched)YESN/AYESN/AL2108SW1002SW90012 (switched)YESN/AYESN/AL2108SW1002 Switching instrumentSW90012 (switched)YESYESYESN/AL2108SW1002 Switching instrumentSW90012 (switched)YESYESYESN/AYESSW90012 (switched)YESYESYESSW50SW9002



Recording results with a dedicated PC application

SW1002

ninal-pair use)

SW1001779-基本計算 ファイル(E) 発きモード(E) 設ま(5)	2-MD 880 AUTO			SW1001アフリ・Cole-Cole7Dット ファイル(*) 発達モード(N) 設計	
CH1: R 1.3202E-003 Q V 3.73378E+000 V	CH2: R 1.3137E-003 Ω V 3.72299E+000 V	CH3: R 1.3171E-003 Ω V 3.72855E+000 V	- #RMR	522 528	40 O.C
CH4: R 1.2819E-003 Q V 3.66999E+000 V	CH5: R 1.3139E-003 Ω V 3.72332E+000 V	CH6: R 1.2788E-003 Ω V 3.66476E+000 V	NER VI	9 H 100	38 7 18 8
CH7: R 1.2821E-003 Q V 3.67032E+000 V	CH8: R 1.2757E-003 Ω V 3.65953E+000 V	CH9: R 1.2790E-003 Ω V 3.66509E+000 V	41001217	-52	2
CH10: R 1.2725E-003 Q V 3.65429E+000 V	CH11: R 1.2759E-003 Ω V 3.65986E+000 V	CH12: R 1.3294E-003 Ω V 3.74906E+000 V		100 294 415 134 632 22 R[Dec] 420	20 110 216 416 134 R[Ohr] 420 016
CH13: R 1.2727E-003 Q V 3.65462E+000 V	CH14: R 1.2976E-003 Ω V 3.69607E+000 V	CH15: R 1.3296E-003 Ω V 3.74939E+000 V		322 E 194	ж Т ³⁴
CH16: R 1.2945E-003 Q V 3.69083E+000 V	CH17: R 1.2978E-003 Ω V 3.69640E+000 V	CH18: R 1.2913E-003 Ω V 3.68560E+000 V	25-11 2018/05/10 15 01 54 045-01	42	× =
CH19: R 1.2947E-003 Ω V 3.69116E+000 V	CH20: R 1.2882E-003 Ω V 3.68037E+000 V	CH21: R 1.2915E-003 Ω V 3.68593E+000 V	2018/05/10 15:02:54 #:#HTE: 0:01:00	-170 100 294 415 534 652 77 P[[Dec]	-723 180 248 416 534 R[Olive]
CH22: R 1.2850E-003 Q V 3.67513E+000 V				27-95.	
EFIS: DATHET Ver:	NO.941 NO.941<	20=10 MBON 20⇒1: 1 T.#: 17 MB™: 12	停止 中	3/4-97/848 67%: DW1001 3/41 97: R0-2320 COMI	(12):541 17:5: 242135 Vec 37: R0-2125 COH1

Logging function (Interval setting: 1 second to 60 minutes) Multichannel Nyquist or Cole-Cole plot



ouloululo				5101					
Instrument	Module	Number of channels	Function	Measurement speed	Measure response				
BT3562A	SW9001	11	ΩV	EX. FAST	10 m				
D13302A	3009001	11	120	MEDIUM	10 m				
		6		FAST	0 ms				
BT4560	SW9002	6	RX	MEDIUM	0 ms				
		22		0.02 PLC*	0 ms				
DM7276	SW9001	22	V	FAST	0 ms				
		22		MEDIUM	0 ms				
*Power Line Cu	Power Line Cycle 20 ms at 50 Hz, 16 7 ms at 60 Hz								

*Power Line Cycle 20 ms at 50 Hz, 16.7 ms at 60 Hz







SW9001 SW9002 SW1001 SW1002: accomodates up to 12 SW9001 or SW9002 modules SW1001: accomodates up to 3 SW9001 or SW9002 modules SW9001 (2-terminal use, 4-terminal use), SW9002 (4-terminal-pair use)

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3562-01, BT3563-01, BT4560, DM7276



Logging function

Measure and log up to 264 channels.

OCV measurement function Measure OCVs, and additionally record the initial voltages and change rates as well.

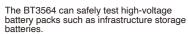
Multichannel Nyquist or Cole-Cole plot Measure impedance while varying the frequency across up to 72 channels and display the results as a Nyquist or Cole-Cole plot. *PC application for SW1001/SW1002.

Internal resistance and open-circuit voltage for various battery types and compatible instruments



Testing high-voltage battery packs safely







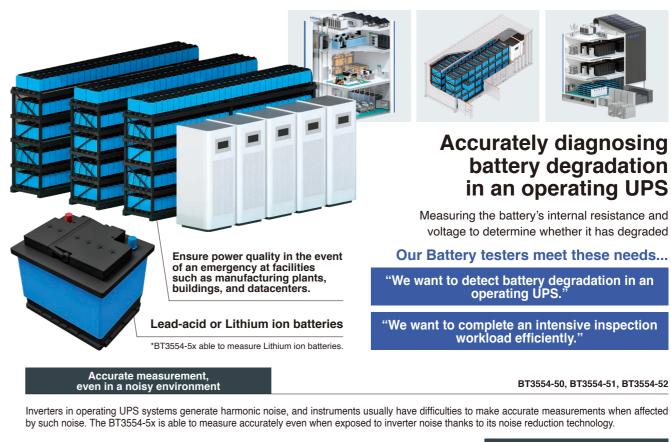
discharges, which are prone to occur during high-voltage measurement, by limiting the amount of current that flows the instant contact is established with a battery pack.

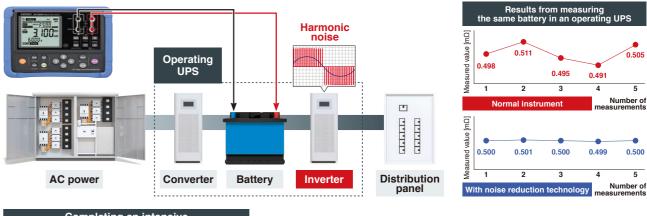


The optional L2110 probe, which is designed specifically for use with the BT3564, can make measurements safely thanks to its 1000 V withstand voltage. Additionally, the probe is designed to accommodate battery packs whose terminals are placed far apart.

Diagnosing degradation in batteries

BT3554-50, BT3554-51, BT3554-52





Completing an intensive inspection workload efficiently

You can efficiently inspect an enormous number of batteries, for example those found in UPS systems, with our free app "GENNECT Cross"



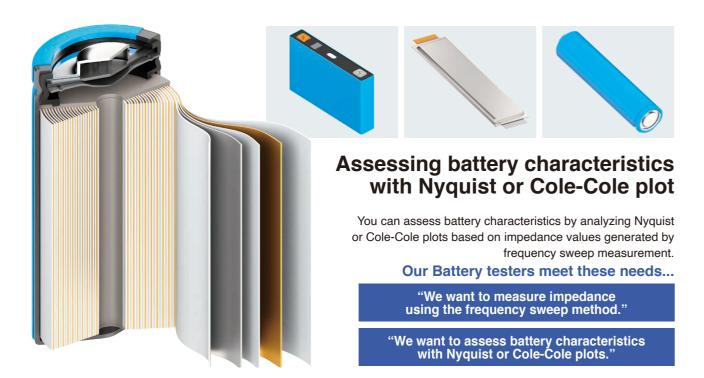
Up to 100 sets of profile information can be registered on the BT3554-5x. Up to 500 data sets can be saved for each profile. (The BT3554-5x can save up to 6,000 data sets.)

To use GENNECT Cross, you must install the Wireless Adapter Z3210 (sold separately) and the GENNECT Cross app on your device. Profile information can be registered on the BT3554-50 from either GENNECT Cross or the desktop application GENNECT ONE.

voltage to determine whether it has degraded

BT3554-50, BT3554-51, BT3554-52

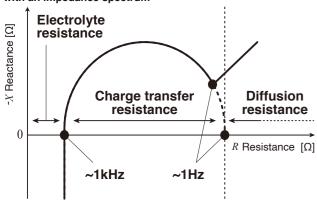
Analyzing batteries BT4560



Assessing battery characteristics

The chemical reactions in batteries involve several processes and each process has its own reaction speed. Therefore by sweeping the frequency and measuring the impedance the characteristics of each part can be evaluated separately.

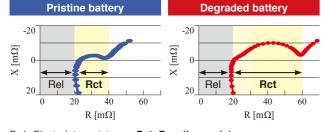
Drawing a Nyquist or Cole-Cole plot with an impedance spectrum



Check the battery deterioration level

The resistance of a degraded battery is significantly larger than a pristine one. The degradation of charge transfer resistance is particularly noticeable in the Nyquist or Cole-Cole plot for applications that involve charging/discharging at low temperatures or deep charging/discharging (SOC between 0% and 100%)

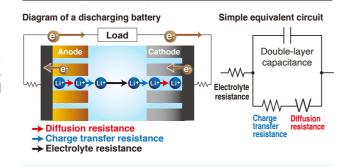




Rel: Electrolyte resistance Rct: Reaction resistance

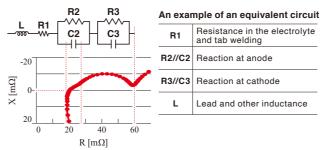
less than 1 Hz	Low frequencies	Li-ion diffusion in the electrode (Diffusion resistance)
1 Hz to several hundred Hz		Li-ion transfer (Charge transfer resistance)
About 1 kHz	High frequencies	Li-ion transport in electrolyte (electrolyte resistance)

BT4560



Idenfity battery deterioration factors

An equivalent circuit analysis software (e.g. ZView®*) can provide the parameters of each element of an equivalent circuit model by means of curve fitting. It allows you to see which part of the battery has shown characteristic changes. This serves to identify battery deterioration factors.



*ZView® is a product of Scribner Associates, Inc.

For more information about ZView®, please contact Scribner Associates, Inc.

surement frequencies and nce m

The BT4560 offers measurements in the optimal frequency range for liquid Li-ion batteries. Its unparalleled capability to measure extremely low impedance is ideal for large cells such as ones for xEVs or ESSs. As a complementary instrument, the IM3590 offers impedance measurements across a wider frequency range. It is very capable at measuring larger impedance.

Model		Me	Measurement frequency				Impedance measurement ranges
BT4560 (Standard specification)			0.1 Hz to 1050 Hz			5 V	3 mΩ, 10 mΩ, 100 mΩ
BT4560 (Special specifications for 20 V)			0.1 Hz to 1050 Hz			20 V	30 mΩ, 300 mΩ, 3 Ω
BT4560 (Special specifications for 10 mHz)		0.01	Hz to 1050 Hz			5 V	3 mΩ, 10 mΩ, 100 mΩ
BT4560 (Special specifications for 20 V, 10 mHz)		0.01	Hz to 1050 Hz			20 V	30 mΩ, 300 mΩ, 3 Ω
BT4560 (Special specifications for 10 kHz)		0.01	0.01 Hz to 10 kHz			5 V	3 mΩ, 10 mΩ, 100 mΩ
IM3590	1 mH	z to 20	to 200 kHz				100 m Ω to 100 M Ω

In the case battery voltage is over 20 V, please contact distributors or sales branches.

BT4560 Accuracy specifications

Impedance measurement accuracy

	ge (0.1 Hz to 100 Hz) nge, 100 mΩ range	$3 \text{ m}\Omega$ range (110) Hz to 1050 Hz)		neasureme alibration is pe		iracy
R accuracy	$r = \pm (0.004 R + 0.0017 X) [m\Omega] =$	a R accuracy = ±(0.0	$004 R + 0.0052 X) [m\Omega] \pm a$	κ v	Display range	-5.10	0000 V to 5.1
,	$y = \pm (0.004 X + 0.0017 R) [m\Omega] =$			v	Resolution	10 µ ^v	V
	$= \pm 0.4\% \operatorname{rdg} \pm \alpha \left(\sin\theta + \cos\theta \right)$		% rdg $\pm \alpha$ (sin θ + cos θ)	Voltage accuracy	FAST/MED/SL	.OW ±0.0	035% rdg ±5
$\boldsymbol{\theta}$ accuracy	$=\pm 0.1^{\circ}\pm 57.3\frac{\alpha}{z}(\sin\theta + \cos\theta)$	θ accuracy = ±0.3	$^{\circ} \pm 57.3 \frac{\alpha}{z} (\sin\theta + \cos\theta)$	Temperature			
Accuracy	/ graph	Accuracy graph		coefficient	(applied in the rai	nges of 0°C to	o 18°C and 28°
2.0 1.8 1.6 1.4 1.4 1.4 1.4 1.2 1.2					t ure measu 2005 temperat		
× 1.2 1.0 1.0 1.0 1.0 1.0 1.0 1.0 1.0		S 1.2 1.0 0.8 0.6 0.4 0.4 0.4 0.4 0.4 0.4 0.4 0.4		Accuracy	±0.5°C (measurement ±1.0°C (measurement -10.0°C to 9.9°	temperatur	re:
0.0	-90 0 90 180 Phase [•]	0.0 -180 -90	0 90 180 Phase [°]	Temperature coefficient	±0.01°C/°C (applied in the rar	nges of 0°C to	o 18°C and 28°
Impedar	ice accuracy excluding α	Impedance acc	curacy excluding α				
	+ 0.0017 X , 0.004 X + 0.0017 R)		X , 0.004 X + 0.0052 R)				
The units	s of <i>R</i> and <i>X</i> are $[m\Omega]$, α is as sho	wn below		The number of	waveforms		
Range	3 mΩ	10 mΩ	100 mΩ		FAST	MED	SLOW
FAS		60 dgt	60 dgt	0.10 Hz to 66		2 waves	8 waves
α MED		30 dgt	30 dgt	67 Hz to 250		8 waves	32 waves
SLOV	N 8 dgt	15 dgt	15 dgt	260 Hz to 105	0 Hz 8 waves	32 waves	128 waves
Temperatur coefficient							

Measurement probes and specialized jigs



*1: See pages 22 and 23 for compatible probes.

*2: Special-order product. *3: Used when combining the BT4560 with the SW1001/SW1002 and SW9002.

BT4560, IM3590



CHEMICAL IMPEDANCE ANALYZER

V	Display range	-5.10000 V to 5.10000 V				
v	Resolution	10 μV				
Voltage accuracy	FAST/MED/SLOW	±0.0035% rdg ±5 dgt				
Temperature coefficient	±0.0005% rdg ±1 dg (applied in the ranges o	gt / °C f 0°C to 18°C and 28°C to 40°C)				
Temperature measurement accuracy						

Accuracy	±0.5°C (measurement temperature: 10.0°C to 40.0°C) ±1.0°C (measurement temperature: -10.0°C to 9.9°C, 40.1°C to 60.0°C)		
Temperature coefficient	$\pm 0.01^{\circ}\text{C}/^{\circ}\text{C}$ (applied in the ranges of 0°C to 18°C and 28°C to 40°C)		

Cables are also available on a special-order basis Please contact HIOKI for more information

Test fixture for cylindrical batteries to use with the Pin Type Probe L2003



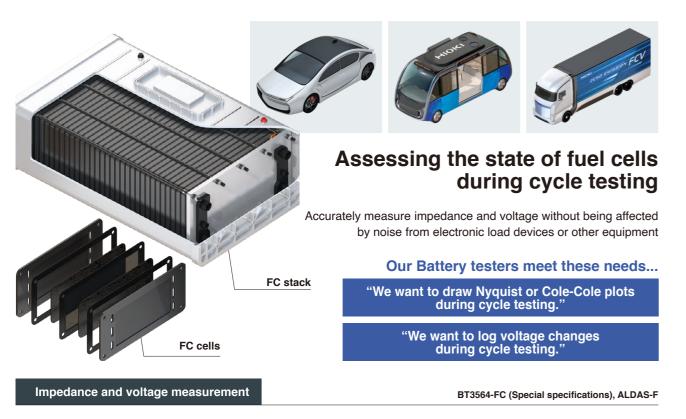




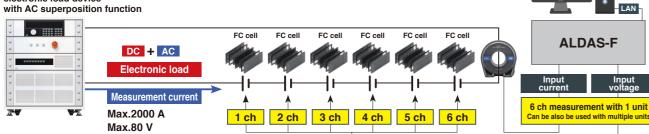
For securing 1 cell'2"3 For securing up to 6 cells'2"3 With batteries attached Connection cord '2"3 (Accommodates 18650, 21700, 4680 and 26650 size cells.)

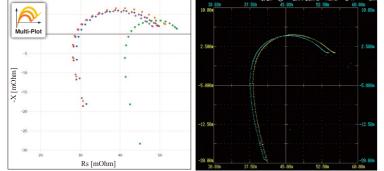
Analyzing fuel cells (FCs)

BT3564-FC (Special specifications), ALDAS-F



Enable to draw Nyquist or Cole-Cole plots along with voltage measurement in an operating FC stack for each cells. electronic load device

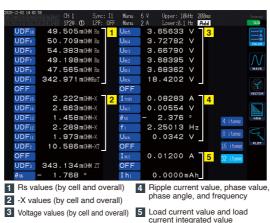




Left: Drawing Nyquist or Cole-Cole plots by the "Multi-plot" application. Right: Drawing Nyquist or Cole-Cole plots bt the ALDAS-F. (Plots can be displayed for up to two channels.)

Model	BT3564-FC/BT3563-FC (Special specifications) (Not CE marked)	ALDAS-F	
Measurement frequency	1 kHz	0.1 Hz to 300 kHz ^{*2}	
Max. measurement voltage	1000 V (BT3564-FC)/300 V (BT3563-FC)	80 V	
Max. allowable input current	Not specified	2000 A	
Number of channels ¹	1 ch	1 ch to 6 ch (× Number of units in use)	

*1: The number of channels can be increased using the SW1001/SW1002. (Maximum allowable voltage: 60 V DC) *2: Plans to support 0.01Hz



USB

-plot

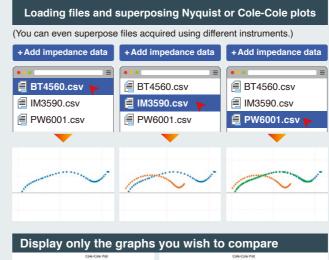
Current sensor lineup

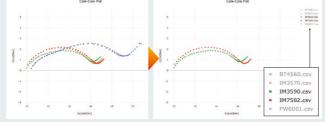
	•			
Appearance	Model	Rated current	Frequency characteristics	Core diameter
Pass-through	CT6904-60	800 A	DC to 4 MHz	ф32 mm
type	CT6904	500 A	DC to 4 MHz	ф32 mm
	CT6877	2000 A	DC to 1 MHz	ф80 mm
	CT6876	1000 A	DC to 1.5 MHz	ф36 mm
the second second	CT6875	500 A	DC to 2 MHz	ф36 mm
Clamp type	CT6841-05	20 A	DC to 1 MHz	ф20 mm
	CT6843-05	200 A	DC to 500 kHz	ф20 mm
	CT6844-05	500 A	DC to 200 kHz	ф20 mm
	CT6845-05	500 A	DC to 100 kHz	φ50 mm
	CT6846-05	1000 A	DC to 20 kHz	φ50 mm

HIOKI Fitting Multi-plot 3D-plot Tutorial Stars 🖸 🛅	t
Worthis wet application, you can post Cale Cale and Bode plots for multiple impedance data simultaneously, just updated StrUFIE can be up one and getter event.	
Add mpedatore data Dilaxi Different Requirements for the input CVI'lle format: Column amounts for frequency, real part of impedance and imaginary part of impedance	Multi-plot
shadi include the words THRQUENCINGT, "T, and "X, respectively. Commany-and actic CV format and an enclose-separated CV format are supported. • Zoke format (z file) is also available. • Develop also apply plays (The Storm here commaces, semicolances, samples	
Caske Halay Tarens et cas HIOKI 6 2011 HOB 17 COMPARING	

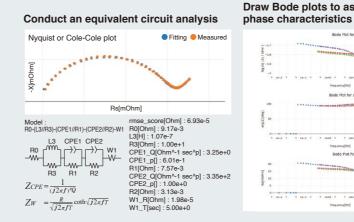


Draw Nyquist or Cole-Cole plots freely, without any limits on the number of points that can be rendered from files or the number of graphs that can be superposed. The horizontal and vertical axes are automatically scaled based on the graphs being rendered. You can even superpose, compare, and analyze files acquired using different instruments.





Analysis function



Display analysis results automatically assess phase characteristics. simply by loading a file.

Neb application "Multi-plot"

Converting measurement data into a Nyquist or Cole-Cole plot

web browser link

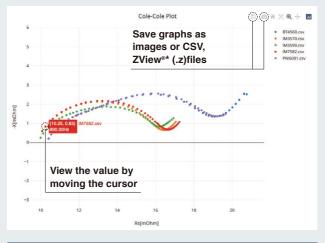
https://www.circuitfitting.net/multiplot

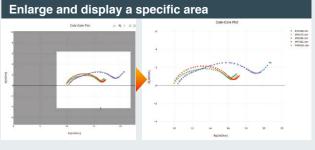
Multi-plot", a free web application, enables you to draw

Nyquist or Cole-Cole plot simply by loading a file in your web browser. Supported files: CSV file, ZView^{®*} (.z) file

Supported instruments: BT4560, PW6001, IM3536 , IM3570, IM3590, IM758x





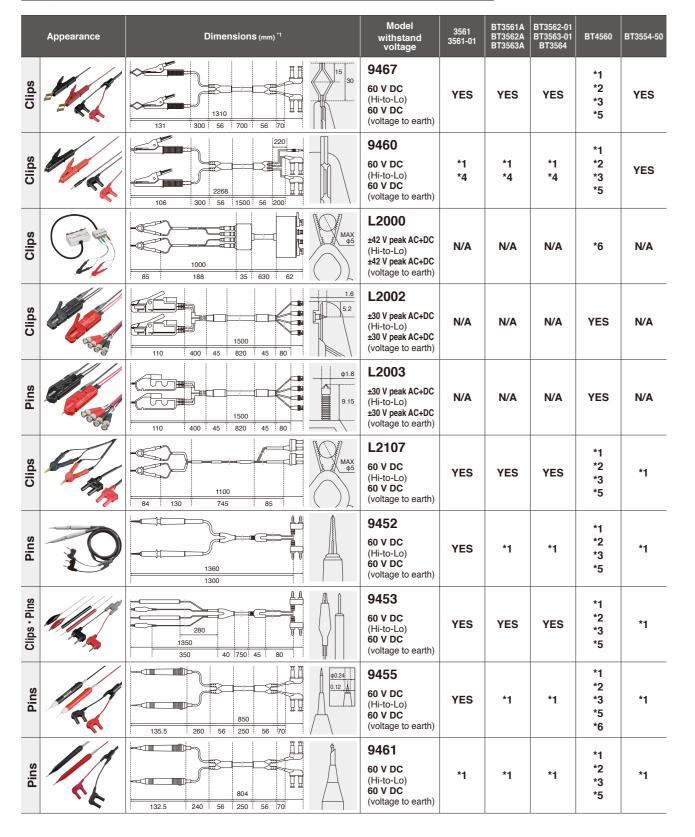


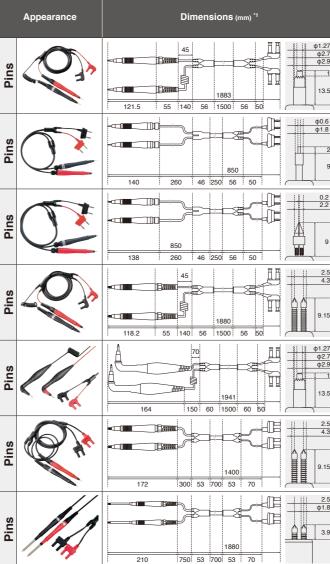
Draw Bode plots to assess Analyze characteristics with 3D view 874580.cm 193570.cm 193590.cm 193590.cm Bode Plot for arg(874580.5% 1913570.5% 1913590.5% 1913590.5% Rotate the 5 18-3 2 5 1840 2 5 1841 2 5 1842 graph in 3D BT 4580, mix
 343570, mix
 343590, mix
 347582, mix
 347582, mix s 1840 2 5 1841 2 1 18+2 2 1 18+3 Analyze the data with predefined models. Bode plots are also drawn, enabling to Draw 3D Nyquist or Cole-Cole plots or 3D

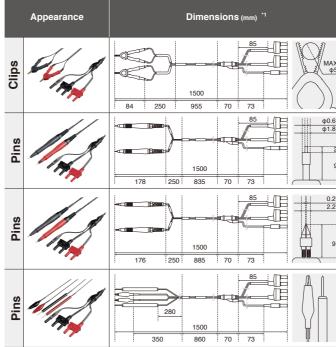
Bode plots, using the time or date as a third axis. Rotate 3D graphs in any direction as desired and save images.

Measurement lead and measurement probe compatibility chart

- YES : Recommended measurement lead or measurement probe listed in brochures.
- N/A : Not compatible due to inability to connect. *1 : Not subject to accuracy guarantee.
- May be susceptible to external noise.
- *2 Caution is particularly required when using a measurement current of 10 mA or less
- BNC banana plug adapter (See page 19) *3
- Connect the black banana plugs to the HCUR and HPOT terminals to reduce the influence from external noise
- *4 : Temperature sensor cannot be connected.
- *5 : It does not use a 4-terminal-pair design, so wiring placement will have a greater effect on measured values.
- *6 : Some measurement ranges cannot be used due to rated current limitations.







*1: Dimensions other than overall length include typical values. *2: HIOKI recommends measurement leads without separate guard terminals: L2101 - L2107, L2102 - 9770, L2103 - 9771, L2104 - 9453

	Model withstand voltage	3561 3561-01	BT3561A BT3562A BT3563A	BT3562-01 BT3563-01 BT3564	BT4560	BT3554-50
27	9465-10 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
.6 .8 2 9	9770 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
9	9771 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
15	9772 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
27	L2020 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
15	L2100 1000 V DC (Hi-to-Lo) 1000 V DC (voltage to earth)	*1	YES	YES	*2 *3 *5	*2
.5	L2110 1000 V DC (Hi-to-Lo) 1000 V DC (voltage to earth)	*1	YES	YES	N/A	N/A

	Model withstand voltage	3561 3561-01	BT3561A BT3562A BT3563A	BT3562-01 BT3563-01 BT3564	BT4560	BT3554-50
	L2101 ^{*2} 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
.6 .8 2 9	L2102 ^{*2} 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
9	L2103 ^{*2} 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
	L2104^{*2} 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2

Batteries are a driving force for a variety of innovations as we move towards a sustainable society

Batteries are used in an array of applications, and their performance can be a driving force for a variety of innovations and new lifestyles. The development and production of high-quality batteries will play an essential role as we work to realize a sustainable society. At the same time therefore, growing improvements in battery life cycle assessment have become a major priority. the focus on reducing CO2 emissions throughout the entire life cycle by means of improvements in manufacturing processes and reuse of high-quality batteries is increasing. HIOKI battery testers are helping resolve these issues through an electrical measurement approach.

Stacked battery voltage, Internal resistance of battery cells



Ueda, Nagano 386-1192 Japan https://www.hioki.com/

Scan for all regional contact information